

CX1V CRYSTAL

10 kHz to 600 kHz

Miniature Quartz Crystal for Pierce Oscillators

DESCRIPTION

The CX1V quartz crystal is a high-quality tuning fork resonator for use in Pierce (single inverter) oscillators. The CX1V is hermetically sealed in a rugged, miniature ceramic package, one-fourth the size of an eight-pin mini-DIP. The CX1V crystal is manufactured using the STATEK-developed photolithographic process, and was designed utilizing the experience acquired by producing millions of crystals for industrial, commercial, military and medical applications.

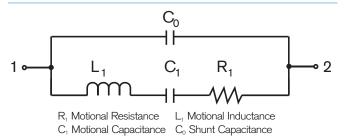
FEATURES

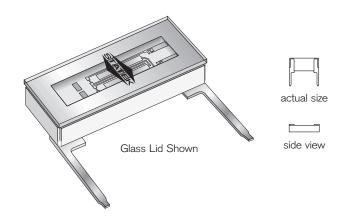
- Miniature tuning fork design
- High shock resistance
- Designed for low power applications
- Compatible with hybrid or PC board packaging
- Low aging
- Full military testing available
- Ideal for battery operated applications
- Designed and manufactured in the USA

PACKAGE HANDLING

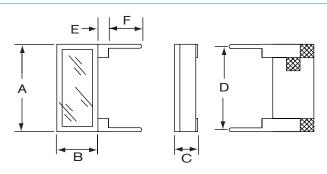
The CX crystal is hermetically sealed in a ceramic package. Normal handling and soldering precautions for small, low thermal mass parts are adequate when installing or testing CX crystals. CX crystals may be wave soldered, with proper precaution taken to avoid desoldering the leads. A slow machine rate or too high a pre-heat temperature or solder bath temperature can damage the crystals. Lead to package solder interface temperature should not exceed 200°C for RoHS compliant version and 175°C for non-RoHS version, glass lid to package seal rim temperature should not exceed 210°C. If the seal rim reaches temperatures above the maximum specified, the package may lose its hermeticity. Loss of hermeticity results in a frequency decrease and motional resistance increase.

EQUIVALENT CIRCUIT





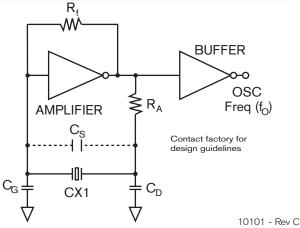
PACKAGE DIMENSIONS



	TYP.		MAX.	
DIM	INCHES	mm	INCHES	mm
А	0.315	8.00	0.330	8.38
В	0.140	3.56	0.155	3.94
С	0.070	1.78	0.080	2.03
D	0.300	7.62	0.310	7.87
Е	0.020	0.51	0.040	1.02
F	0.150	3.81	0.160	4.06

Leads 0.013" x 0.018" (0.33 x 0.46 mm) typical.

CONVENTIONAL CMOS PIERCE OSCILLATOR CIRCUIT



SPECIFICATIONS

Specifications are typical at 25°C unless otherwise noted. Specifications are subject to change without notice.

Frequency Range 10 kHz to 600 kHz

Calibration Tolerance¹ (see below) Motional Resistance (R₁) Figure 1

MAX.: 2x Typ.@10-169.9 kHz

2.5x Typ.@170-600 kHz

Motional Capacitance (C₁) Figure 2 Quality Factor (Q) Figure 3

Min. is 0.25x Typ.

Shunt Capacitance (C_0) 2.0 pF MAX.

Drive Level 0.5 μW MAX.@10-24.9 kHz 1.0 μW MAX.@ 25-600 kHz

Turning Point $(T_0)^2$ Figure 4

Temperature Coefficient (k) -0.035 ppm/°C² Aging, first year 5ppm MAX.

Shock, survival³ 1,000 G peak 1ms, 1/2 sine 20 G RMS 10-2,000 Hz Vibration, survival³ Operating Temperature -10°C to +70°C (Commercial) -40°C to +85°C (Industrial)

-55°C to +125°C (Military) -55°C to +125°C Storage Temperature Max Process Temperature 175°C for -03 version

200°C for -05 version

- 1. Tighter frequency calibration available.
- 2. Other turning point available.
- 3. Higher shock and vibration available.

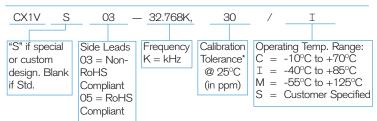
Load Capacitance (C₁), Used to Calibrate CX-1V (other C_L available)

Frequency	Load	Frequency	Load
Range	Capacitance	Range	Capacitance
(kHz)	(pF)	(kHz)	(pF)
10-15.9	11	55-99.9	8
16-24.9	10	100-179.9	5
25-54.9	9	180-600	4

CX1V Standard Calibration Tolerance at 25°C

Frequency Range (kHz)						
10-74.9	75-169.9	170-249.9	250-600			
± 30 ppm	± 50 ppm	±100 ppm	±200 ppm			

HOW TO ORDER CX1V LEADED CRYSTALS



*The above table provides the best calibration tolerance available for each frequency range at 25°C.

FIGURE 1 CX1V TYPICAL MOTIONAL RESISTANCE (R1)

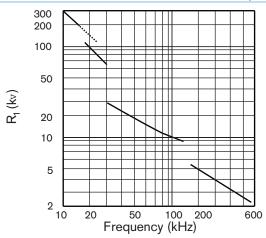


FIGURE 2 CX1V TYPICAL MOTIONAL CAPACITANCE (C1)

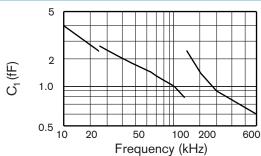


FIGURE 3 CX1V TYPICAL QUALITY FACTOR (Q)

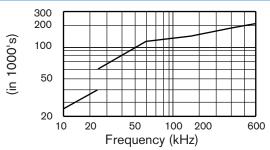
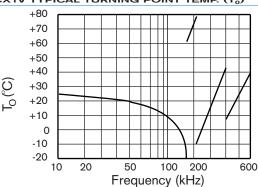


FIGURE 4 CX1V TYPICAL TURNING POINT TEMP. (To)



Note: Frequency (f) deviation from frequency (f_0) @ turning point temperature (T_0) : $= k(T-T_0)^2$

PACKAGING FOR LEADED CRYSTALS

CX1V - Tray Pack (Standard)